



AOA400

N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOA400 uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. Standard Product AOA400A400 is Pbfree (meets ROHS & Sony 259 specifications). AOA400L is a Green Product ordering option. AOA400 and AOA400L are electrically identical.

Features

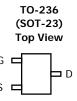
 $V_{DS}(V) = 30V$

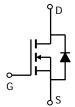
 $I_D = 2.8 \text{ A } (V_{GS} = 10 \text{V})$

 $R_{DS(ON)}$ < 85m Ω (V_{GS} = 10V)

 $R_{DS(ON)} < 100 m\Omega (V_{GS} = 4.5 V)$

 $R_{DS(ON)}$ < 140m Ω (V_{GS} = 2.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	30	V				
Gate-Source Voltage		V_{GS}	±12	V				
Continuous Drain	T _A =25°C		2.8					
Current ^A	T _A =70°C	I _D	2.3	A				
Pulsed Drain Current ^B		I _{DM}	10					
	T _A =25°C	В	1.1	10/				
Power Dissipation ^A	T _A =70°C	$-P_D$	0.73	W				
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C				

Thermal Characteristics									
Parameter	Symbol	Тур	Typ Max Unit						
Maximum Junction-to-Ambient A	t ≤ 10s	D	82	110	°C/W				
Maximum Junction-to-Ambient ^A	Steady-State	y-State $R_{\theta JA}$		150	°C/W				
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	55	80	°C/W				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Тур	Max	Units
STATIC F	PARAMETERS					
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			1	μА
		T _J =55°C	;		5	μΑ
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±12V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	0.6	1	1.5	V
$I_{D(ON)}$	On state drain current	V _{GS} =4.5V, V _{DS} =5V	10			Α
R _{DS(ON)} Si	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =2.8A		59	85	mΩ
		T _J =125°C	;	90	130	11152
	Static Drain-Source On-Nesistance	V_{GS} =4.5V, I_{D} =2.5A		68	100	mΩ
		V_{GS} =2.5V, I_D =2A		102	140	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =2.8A		8		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.8	1	V
I _S	Maximum Body-Diode Continuous Curr			1.5	Α	
DYNAMIC	CPARAMETERS					
C _{iss}	Input Capacitance			390		pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		54.5		pF
C_{rss}	Reverse Transfer Capacitance			41		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		8		Ω
SWITCHI	NG PARAMETERS					
Q_g	Total Gate Charge			4.2		nC
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =15V, I_{D} =2.8A		0.56		nC
Q_{gd}	Gate Drain Charge			1.4		nC
t _{D(on)}	Turn-On DelayTime			2.9		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =5.6 Ω ,		1.8		ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =6 Ω		23		ns
t _f	Turn-Off Fall Time			3.4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =2.8A, dI/dt=100A/μs		10		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =2.8A, dI/dt=100A/μs		2.6		nC

A: The value of $R_{\theta,JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using $80\,\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25 °C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

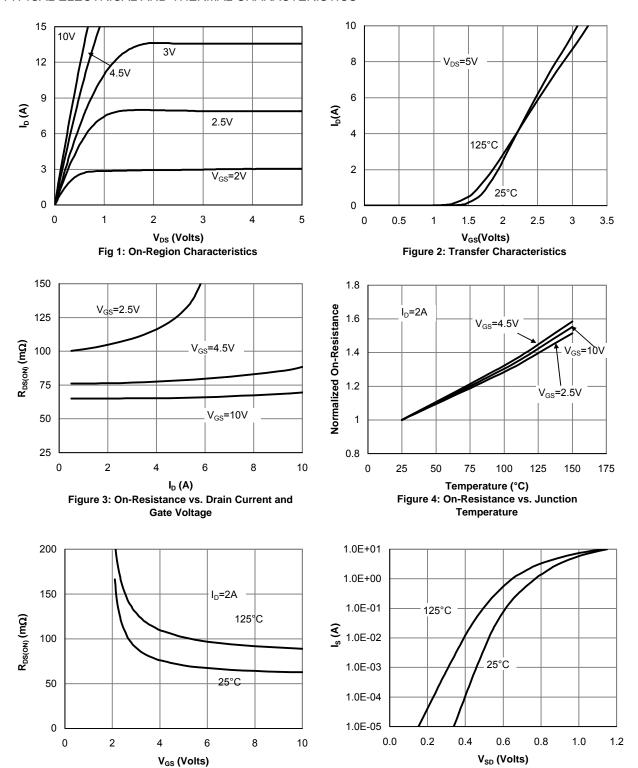


Figure 6: Body-Diode Characteristics

Figure 5: On-Resistance vs. Gate-Source Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

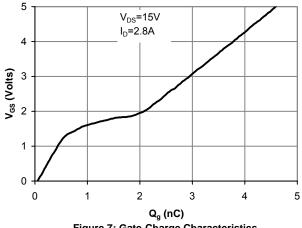


Figure 7: Gate-Charge Characteristics

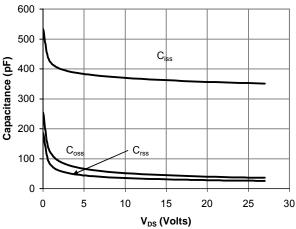


Figure 8: Capacitance Characteristics

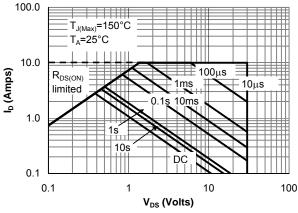


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

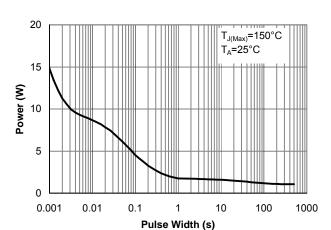


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

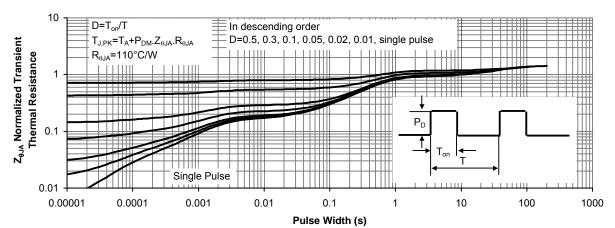


Figure 11: Normalized Maximum Transient Thermal Impedance